

SEMITOP[®] 2

IGBT Module

SK30GB123

SK30GAL123

SK30GAR123

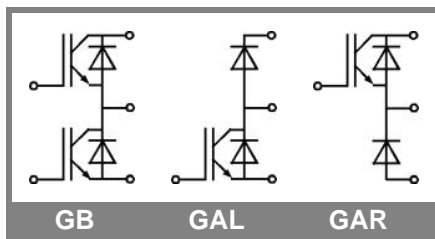
Preliminary Data

Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- N-channel homogeneous silicon structure (NPT-Non punch-through IGBT)
- High short circuit capability
- Low tail current with low temperature dependence

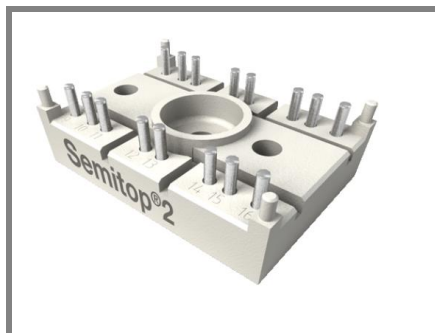
Typical Applications

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



Absolute Maximum Ratings		$T_s = 25\text{ °C}$, unless otherwise specified	
Symbol	Conditions	Values	Units
IGBT			
V_{CES}	$T_j = 25\text{ °C}$	1200	V
I_C	$T_j = 125\text{ °C}$	$T_s = 25\text{ °C}$	33 A
		$T_s = 80\text{ °C}$	22 A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	50	A
V_{GES}		± 20	V
t_{psc}	$V_{CC} = 600\text{ V}; V_{GE} \leq 20\text{ V}; T_j = 125\text{ °C}$ $V_{CES} < 1200\text{ V}$	10	μs
Inverse Diode			
I_F	$T_j = 150\text{ °C}$	$T_s = 25\text{ °C}$	37 A
		$T_s = 80\text{ °C}$	25 A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$		A
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150\text{ °C}$	350	A
Module			
$I_{t(RMS)}$			A
T_{vj}		-40 ... +150	$^{\circ}\text{C}$
T_{stg}		-40 ... +125	$^{\circ}\text{C}$
V_{isol}	AC, 1 min.	2500	V

Characteristics		$T_s = 25\text{ °C}$, unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 1\text{ mA}$	4,5	5,5	6,5	V	
I_{CES}	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}$	$T_j = 25\text{ °C}$		0,15	mA	
		$T_j = 125\text{ °C}$			mA	
I_{GES}	$V_{CE} = 0\text{ V}, V_{GE} = 30\text{ V}$	$T_j = 25\text{ °C}$		120	nA	
		$T_j = 125\text{ °C}$			nA	
V_{CE0}		$T_j = 25\text{ °C}$	1,2		V	
		$T_j = 125\text{ °C}$	1,2		V	
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}$	52		$\text{m}\Omega$	
		$T_j = 125\text{ °C}$	76		$\text{m}\Omega$	
$V_{CE(sat)}$	$I_{Cnom} = 25\text{ A}, V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}_{chiplev.}$	2	2,5	3	V
		$T_j = 125\text{ °C}_{chiplev.}$		3,1	3,7	V
C_{ies}	$V_{CE} = 25, V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	1,65		nF	
C_{oes}			0,25		nF	
C_{res}			0,11		nF	
$t_{d(on)}$	$R_{Gon} = 25\ \Omega$	$V_{CC} = 600\text{ V}$ $I_{Cnom} = 25\text{ A}$	40		ns	
t_r			45		ns	
E_{on}	$R_{Goff} = 25\ \Omega$	$T_j = 125\text{ °C}$ $V_{GE} = \pm 15\text{ V}$	3,5		mJ	
$t_{d(off)}$			300		ns	
t_f			45		ns	
E_{off}			2,6		mJ	
$R_{th(j-s)}$	per IGBT			1	K/W	



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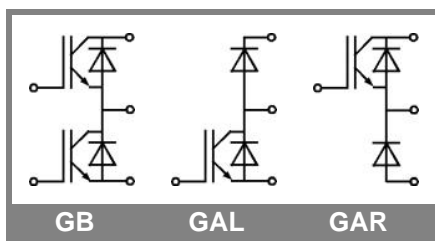
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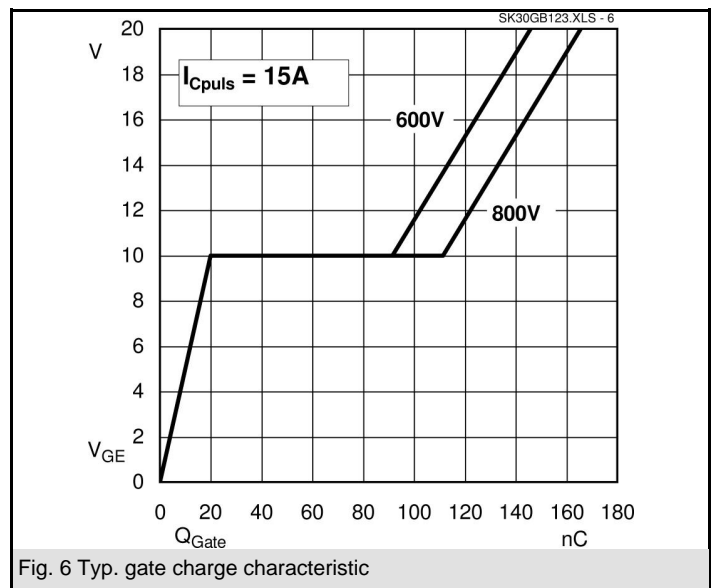
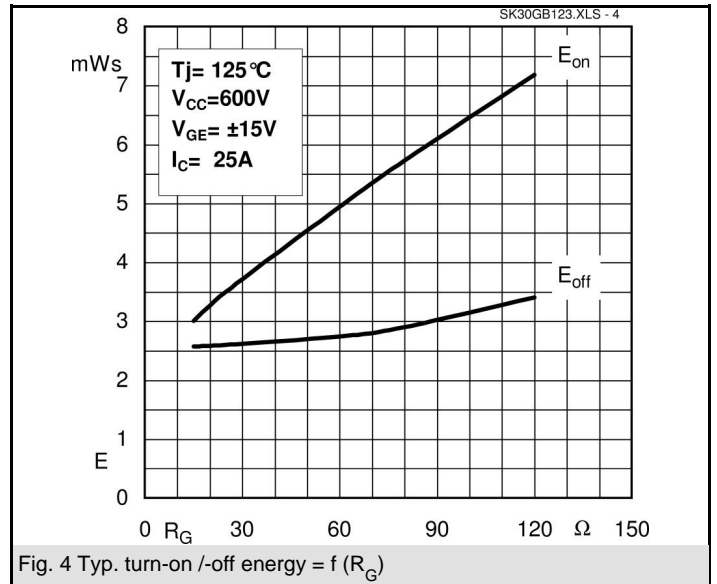
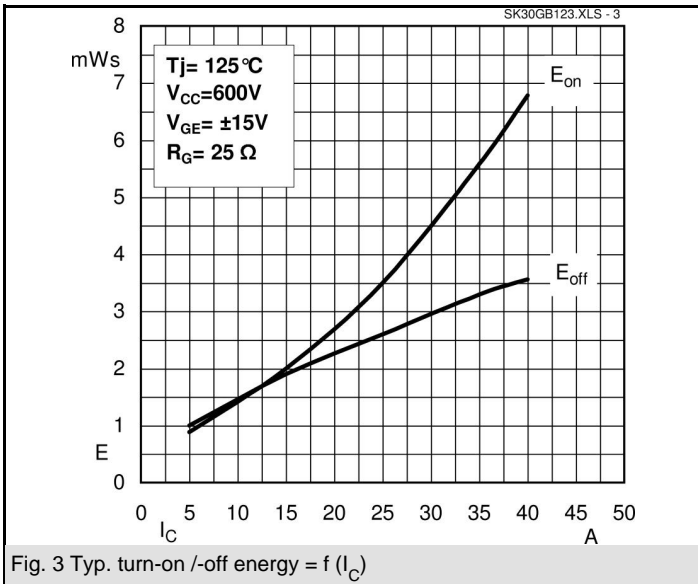
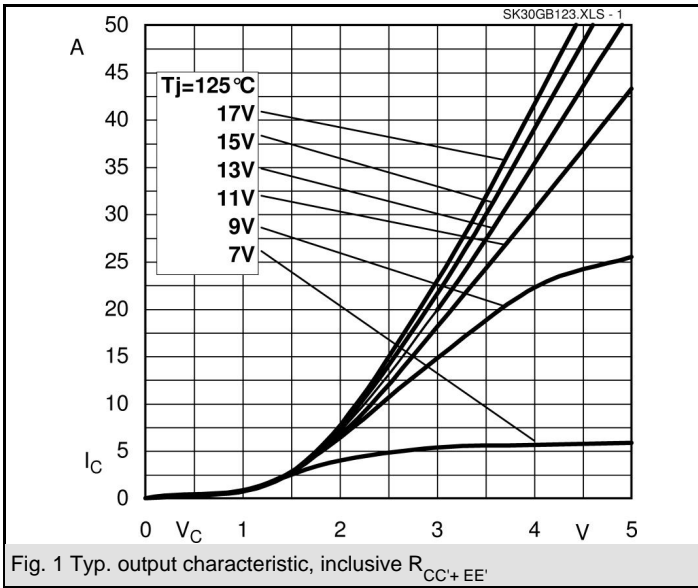


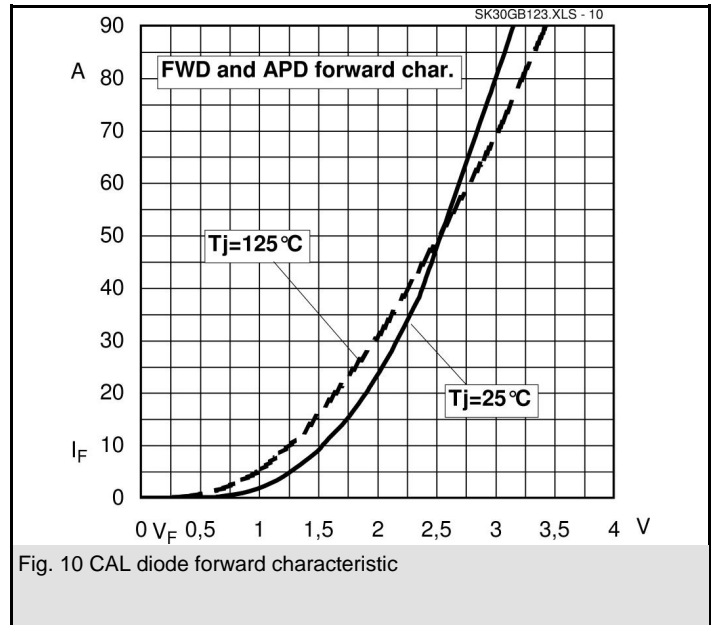
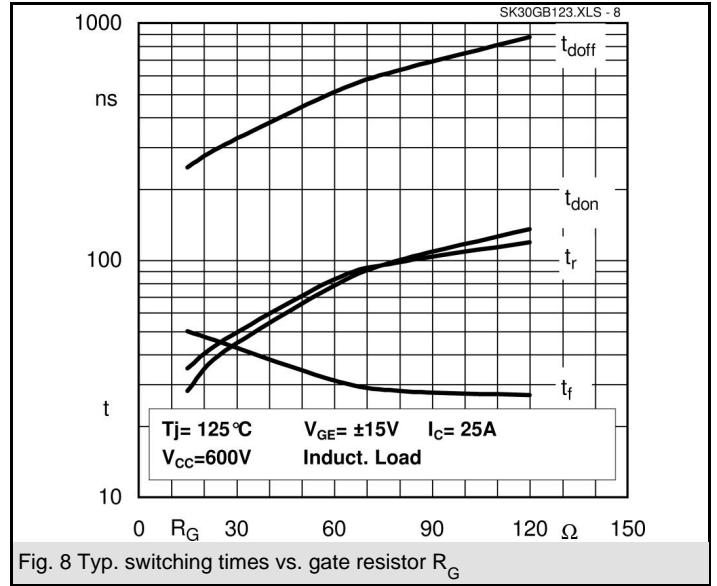
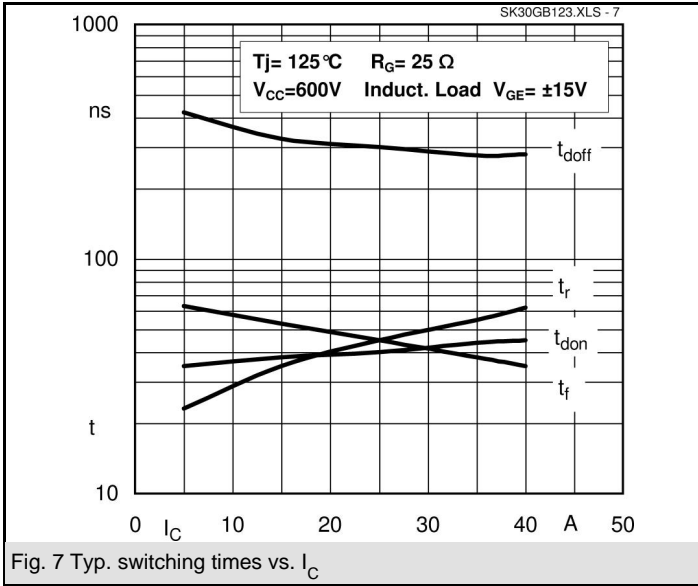
Characteristics

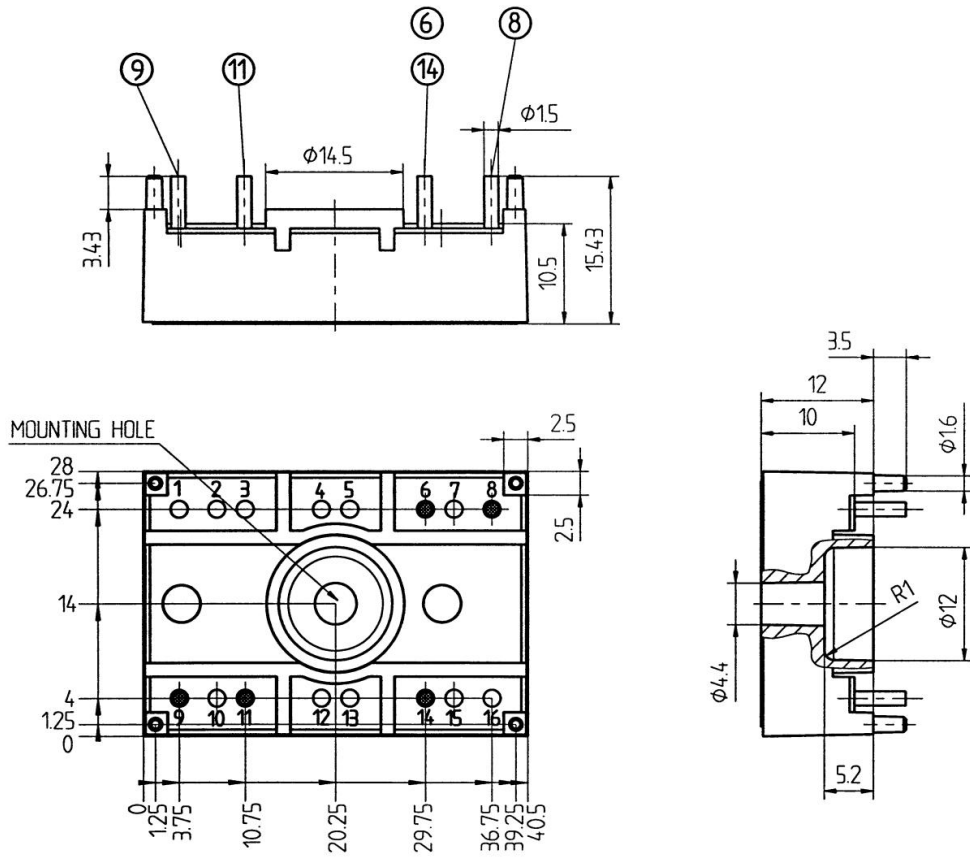
Symbol	Conditions	min.	typ.	max.	Units	
Inverse Diode						
$V_F = V_{EC}$	$I_{Fnom} = 25 \text{ A}; V_{GE} = 0 \text{ V}$		$T_j = 25 \text{ }^\circ\text{C}_{\text{chiplev.}}$	2	2,5	V
			$T_j = 125 \text{ }^\circ\text{C}_{\text{chiplev.}}$	1,8	2,3	V
V_{F0}			$T_j = 125 \text{ }^\circ\text{C}$	1	1,2	V
r_F			$T_j = 125 \text{ }^\circ\text{C}$	32	44	mΩ
I_{RRM}	$I_{Fnom} = 22 \text{ A}$ $di/dt = -500 \text{ A}/\mu\text{s}$		$T_j = 125 \text{ }^\circ\text{C}$	25		A
Q_{rr}				4,5		μC
E_{rr}	$V_{CC} = 600\text{V}$			1		mJ
$R_{th(j-s)D}$	per diode			1,2		K/W
M_s	to heat sink M1			2		Nm
w				19		g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.







Case T8 (Suggested hole diameter, in the PCB, for solder pins and plastic mounting pins: 2mm)

